

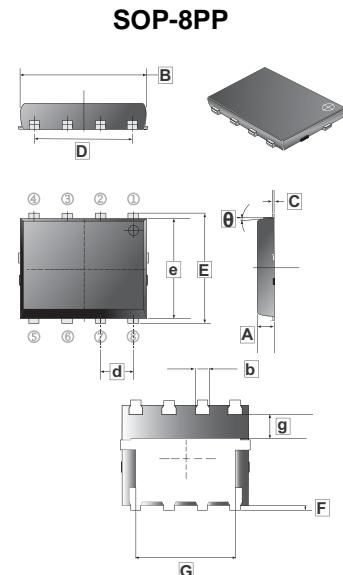
RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low $R_{DS(on)}$ and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

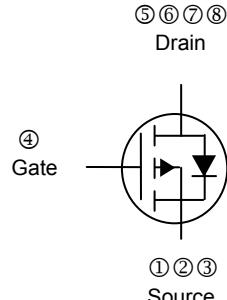
FEATURES

- Low $R_{DS(on)}$ provides higher efficiency and extends battery life.
- Low thermal impedance copper leadframe SOP-8PP saves board space.
- Fast switching speed.
- High performance trench technology.



PRODUCT SUMMARY

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$V_{DS(V)}$	$R_{DS(on)}$ (mΩ)	$I_D(A)$
-60	45@ $V_{GS} = -10V$	-10
	60@ $V_{GS} = -4.5V$	-8



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	1.00	1.10	θ	0°	12°
B	5.70	5.80	b	0.33	0.51
C	0.20	0.30	d	1.27	BSC
D	3.61	3.98	e	1.35	1.75
E	5.40	6.10	g	1.10	-
F	0.08	0.20			
G	3.60	3.99			

ABSOLUTE MAXIMUM RATINGS AND THERMAL DATA ($T_A = 25^\circ C$ unless otherwise specified)

PARAMETER		SYMBOL	RATING	UNIT
Drain-Source Voltage		V_{DS}	-60	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current ^A	$T_A=25^\circ C$	I_D	-10	A
	$T_A=70^\circ C$		-8	
Pulsed Drain Current ^B		I_{DM}	± 50	A
Continuous Source Current (Diode Conduction) ^A		I_S	-2.1	A
Power Dissipation ^A	$T_A=25^\circ C$	P_D	5.0	W
	$T_A=70^\circ C$		3.2	
Operating Junction and Storage Temperature Range		T_J, T_{STG}	-55 ~ 150	°C
THERMAL RESISTANCE DATA				
Maximum Junction to Ambient ^A	$t \leq 10$ sec	$R_{\theta JA}$	25	°C / W
	Steady-State		65	

Notes

- Surface Mounted on 1" x 1" FR4 Board.
- Pulse width limited by maximum junction temperature.

ELECTRICAL CHARACTERISTICS ($T_A=25^\circ\text{C}$ unless otherwise specified)

PARAMETER	SYMBO	MIN	TYP	MAX	UNIT	TEST CONDITIONS
Static						
Gate-Threshold Voltage	$V_{GS(\text{th})}$	-1	-	-	V	$V_{DS} = V_{GS}$, $I_D = -250\mu\text{A}$
Gate-Body Leakage	I_{GSS}	-	-	± 100	nA	$V_{DS} = 0\text{V}$, $V_{GS} = \pm 25\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	-1	μA	$V_{DS} = -48\text{V}$, $V_{GS} = 0\text{V}$
		-	-	-5		$V_{DS} = -48\text{V}$, $V_{GS} = 0\text{V}$, $T_J = 55^\circ\text{C}$
On-State Drain Current ^A	$I_{D(\text{ON})}$	-50	-	-	A	$V_{DS} = -5\text{V}$, $V_{GS} = -10\text{V}$
Drain-Source On-Resistance ^A	$R_{DS(\text{ON})}$	-	-	45	$\text{m}\Omega$	$V_{GS} = -10\text{V}$, $I_D = -9\text{A}$
		-	-	60		$V_{GS} = -4.5\text{V}$, $I_D = -7.2\text{A}$
Forward Transconductance ^A	g_{FS}	-	31	-	S	$V_{DS} = -15\text{V}$, $I_D = -9\text{A}$
Diode Forward Voltage	V_{SD}	-	-0.7	-	V	$I_S = 2.1\text{A}$, $V_{GS} = 0\text{V}$
Dynamic ^b						
Total Gate Charge	Q_g	-	15.3	-	nC	$I_D = -9\text{A}$
Gate-Source Charge	Q_{gs}	-	5.2	-		$V_{DS} = -15\text{V}$
Gate-Drain Charge	Q_{gd}	-	5.8	-		$V_{GS} = -4.5\text{V}$
Turn-On Delay Time	$T_{d(\text{ON})}$	-	15	-	nS	$I_D = -1\text{A}$, $V_{DD} = -15\text{V}$
Rise Time	T_r	-	12	-		$V_{GEN} = -10\text{V}$
Turn-Off Delay Time	$T_{d(\text{OFF})}$	-	62	-		$R_L = 15\Omega$
Fall Time	T_f	-	46	-		$R_G = 6\Omega$

Notes

- a. Pulse test : $PW \leq 300\text{ us}$ duty cycle $\leq 2\%$.
- b. Guaranteed by design, not subject to production testing.